

Notice of References Cited	Application/Control No. 09/761,981	Applicant(s)/Patent Under Reexamination SWANSON, DAVID K.	
	Examiner Peter J Vrettakos	Art Unit 3739	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,792,140	08-1998	Tu et al.	606/41
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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